FCC PART 15 CLASS B EMI MEASUREMENT AND TEST REPORT

For

Shanghai Dare Technologies Co., Ltd

22 F Shanghai Information Building No. 1555 KongJiang Road, Shanghai, China

FCC ID: RS3DB120

2004-09-09

This Report Concerns:		Equipment Type:				
🛛 Original Report		ADSL Modem				
Test Engineer:	Jerry Wang / Zerry					
Report No.:	R0408204					
Test Date:	2004-08-21					
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GENERAL INFORMATION

Product Description for Equipment Under Test (EUT)

The *Shanghai Dare Technologies Co. Ltd's* product, model DB120 or the "EUT" as referred to in this report is the ADSL Modem which measures approximately 170mmL x 125mmW x 30mmH.

*The test data gathered are from production sample, serial number: AL0530026, provided by the manufacturer.

Objective

This test report is prepared on behalf of *Shanghai Dare Technologies Co. Ltd* in accordance with Part 2, Subpart J, and Part 15, Subparts A and B of the Federal Communication Commissions rules and regulations and to ICES-003 of the Canadian Interference-Causing Equipment Regulations.

The objective is to determine compliance with FCC Class B limits for Information Technology Equipment.

Related Submittal(s)/Grant(s)

No Related Submittals.

Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2001, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

All radiated and conducted emissions measurements were performed at BACL.

Test Facility

The Open Area Test site used by BACL to collect radiated and conducted emission measurement data is located in the back parking lot of the building at 230 Commercial Street, Sunnyvale, California, USA.

Test site at BACL has been fully described in reports submitted to the Federal Communication Commission (FCC) and Voluntary Control Council for Interference (VCCI). The details of these reports has been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on February 11 and December 10, 1997 and Article 8 of the VCCI regulations on December 25, 1997. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-2001.

The Federal Communications Commission and Voluntary Control Council for Interference has the reports on file and is listed under FCC file 31040/SIT 1300F2 and VCCI Registration No.: C-1298 and R-1234. The test site has been approved by the FCC and VCCI for public use and is listed in the FCC Public Access Link (PAL) database.

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Additionally, BACL is a National Institute of Standards and Technology (NIST) accredited laboratory, under the National Voluntary Laboratory Accredited Program (Lab Code 200167-0). The scope of the accreditation covers the FCC Method - 47 CFR Part 15 - Digital Devices, CISPR 22:2002 Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment test methods under NVLAP Lab Code 200167-0.

SYSTEM TEST CONFIGURATION

Justification

The system was configured for testing according to ANSI C63.4-2001.

EUT Exercise Software

The EUT exercising program used during radiated and conducted testing was designed to exercise the various system components.

Special Accessories

As shown in test setup block diagram, interface cable used for compliance testing are shielded and supplied by applicant and/or its respective support equipment manufacturers.

Schematics / Block Diagram

Please refer to Exhibit C.

Equipment Modifications

No modifications were made to the EUT.

Local Support Equipment List and Details

Manufacturer	Description	Model	Serial Number	FCC ID
Sony	Notebook	PCG-885L	283520304516747	DOC
HP	Printer	Thinkjet 2225C	2512S43681	BS46XU2225C

Remote Support Equipment

Manufacturer	Description	Model	Serial Number	FCC ID	
Arescom	Arescom DSL Simulator		B102903	DOC	

External I/O Cabling List and Details

Cable Description	Length (M)	Port/From	То
Phone Line	5.0	Line/EUT	Arescom DSL Simulator
LAN Cable	1.5	LAN Port/EUT	Notebook
Shielded Printer Cable	1.5	Parallel/Host	HP Printer

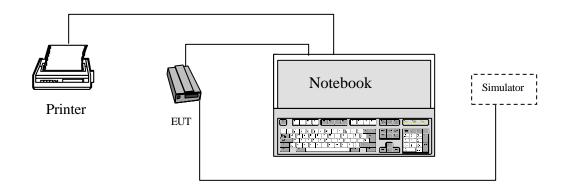
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Power Supply List and Details

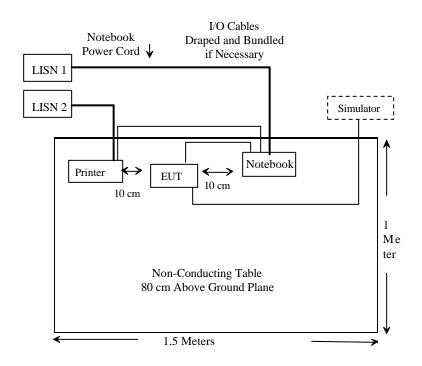
Manufacturer	Description	Model	Serial Number	FCC ID
LEI	120V Power Supply	481207003CT	0350	N/A

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Configuration of Test System



Test Setup Block Diagram



§15.107 - CONDUCTED EMISSIONS

Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, and LISN.

Based on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement at BACL is ± 2.4 dB.

EUT Setup

The measurement was performed in the shield room, using the same setup per ANSI C63.4-2001 measurement procedure. The specification used was the FCC15 Class B limits.

The spacing between the peripherals was 10 cm.

The external I/O cables were draped along the test table and bundled as required.

The notebook was connected to 120Vac/60Hz power source.

Spectrum Analyzer Setup

The spectrum analyzer was set to investigate the spectrum from 150 kHz to 30MHz.

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Cal Date
Rohde & Schwarz	Artificial-Mains Network	ESH2-Z5	871884/039	2004-03-28
Rohde & Schwarz	EMI Test Receiver	ESCS30	100176	2004-05-06
Fluke	Calibrated Voltmeter	189	18485-38	2004-07-18

* **Statement of Traceability: BACL Corp.** attests all calibrations have been performed per the NVLAP requirements, traceable to the NIST.

Test Procedure

During the conducted emission test, the power cord of the host system was connected to the mains outlet of the LISN-1.

Maximizing procedure were performed on the six (6) highest emissions of the EUT.

All data was recorded in the peak detection mode, quasi-peak and average. Average readings are distinguished with an "Ave". Quasi-peak readings are distinguished with an "Qp".

Environmental Conditions

Temperature:	24-28 °C
Relative Humidity:	58%
ATM Pressure:	1016 mbar

The testing was performed by Jerry Wang on 2004-08-21.

Test Results Summary

According to the recorded data in following table, <u>the EUT complied with the FCC</u> Conducted limits for a Class B device, with the worst margin reading of:

Conducted Emissions Test Data:

-1.0 dB at 4.70 MHz on the Neutral conductor.

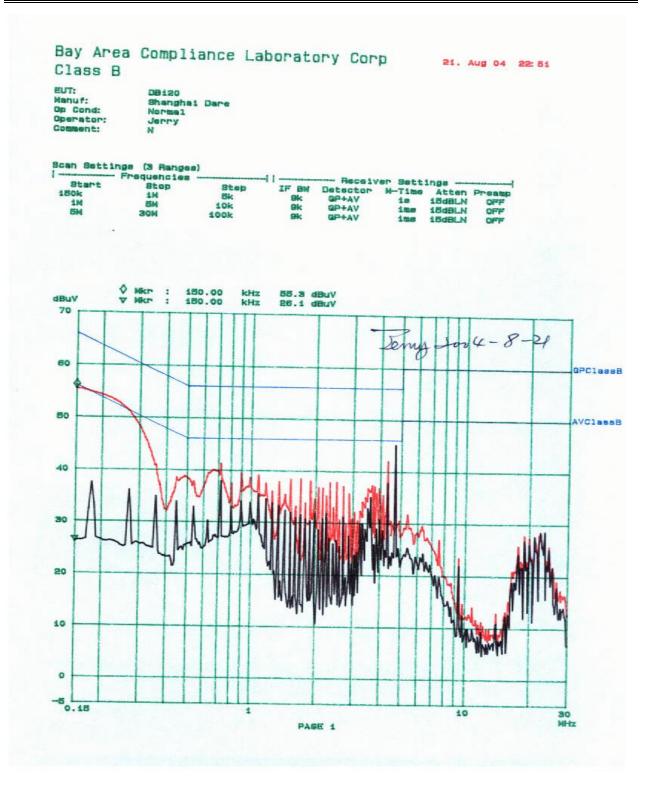
Conducted Emissions Test Data

	LINE COND	FCC CL	ASS B		
Frequency	Amplitude	Detector	Phase	Limit	Margin
MHz	dBµV	Qp/Ave/Peak	Line/Neutral	dBµV	dB
4.70	45.0	Ave	Neutral	46	-1.0
4.71	43.0	Ave	Line	46	-3.0
0.81	40.4	Ave	Line	46	-5.6
0.72	38.0	Ave	Neutral	46	-8.0
0.15	55.4	QP	Neutral	66	-10.6
4.70	45.1	QP	Neutral	56	-10.9
0.15	54.6	QP	Line	66	-11.4
4.71	43.7	QP	Line	56	-12.3
0.81	43.3	QP	Line	56	-12.7
0.72	31.3	QP	Neutral	56	-24.7
0.15	26.3	Ave	Neutral	56	-29.7
0.15	24.4	Ave	Line	56	-31.6

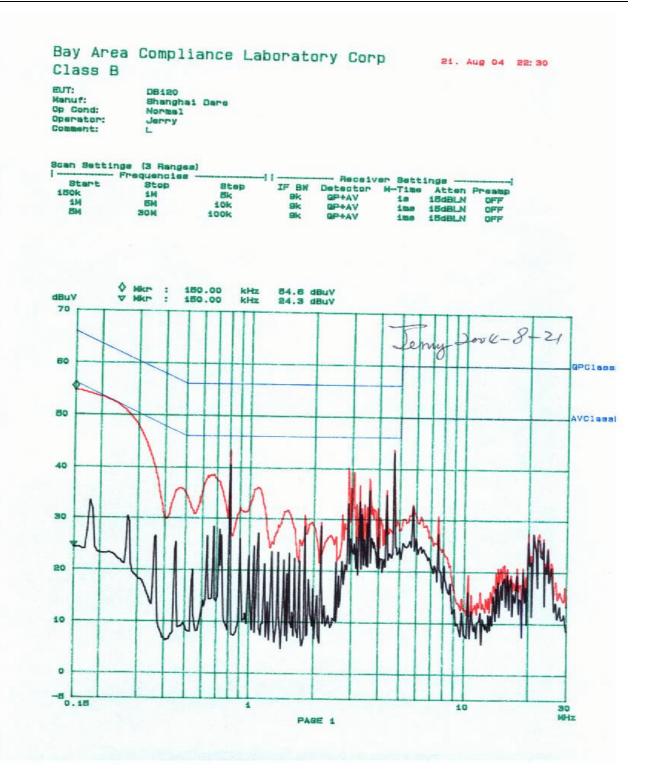
Plot of Conducted Emissions Test Data

Plot(s) of Conducted Emissions Test Data is presented hereinafter as reference.

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FCC 15 Subpart B Report



FCC 15 Subpart B Report

§15.109 - RADIATED EMISSIONS

Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in the field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of a radiation emissions measurement at BACL is ± 4.0 dB.

EUT Setup

The radiated emission tests were performed in the open area 3-meter test site, using the setup in accordance with ANSI C63.4-2001. The specification used in this report was the EN 55022: 1998 + A1: 2000 Class B limits.

The spacing between the peripherals was 10 cm.

The external I/O cables were draped along the test table and bundled as required.

The notebook was connected to 120Vac/60Hz power source.

Spectrum Analyzer Setup

The system was tested to 1000 MHz.

During the radiated emission test, the spectrum analyzer was set with the following configurations:

Frequency Range	RBW	Video B/W
Below 30MHz	10kHz	10kHz
30 - 1000MHz	100kHz	100kHz
Above 1000MHz	1MHz	1MHz

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Cal Date
HP	Spectrum Analyzer	8568B	3019A05393	2004-06-13
HP	Spectrum Analyzer Display	85662A	3026A20081	2004-06-13
HP	Quasi-Peak Adapter	85650A	3107A01505	2003-09-30
Agilent	Amplifier	8447D	2944A10198	2003-09-23
EMCO	Biconical Antenna	3110B	9309-1165	2003-10-11
EMCO	Logperiodic Antenna	3146	2101	2003-10-11

* **Statement of Traceability: BACL Corp.** attests that all calibrations have been performed per the NVLAP requirements, traceable to the NIST.

Test Procedure

For the radiated emissions test, the power cord of the host system and all support equipment were connected to the AC floor outlet.

Maximizing procedure was performed on the six (6) highest emissions in the described configurations.

All data was recorded in the peak detection mode. Quasi-peak readings was performed only when an emission was found to be marginal (within -4 dB of specification limits), and are distinguished with a " \mathbf{Qp} " in the data table.

Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading + Antenna Factor + Cable Factor - Amplifier Gain

The "**Margin**" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the maximum limit for Class B. The equation for margin calculation is as follows:

Margin = Corr. Ampl. - Class B Limit

Summary of Test Results

According to the data in following tables, the EUT <u>complied with the FCC 15 Class B</u> standards, and had the worst margin of:

-0.9 dB at 500 MHz in the Vertical polarization.

Testing performed by Jerry Wang on 2004-08-21, originally saved on server.

Radiated Emissions Test Data

Indica	ATED	Table	Ante	ENNA	Co	RRECTION F	ACTOR	Corrected Amplitude	FCC C	LASS B
Freq.	Ampl.	Angle	Height	Polar	Antenna	Cable	Amp.	Corr. Ampl.	Limit	Margin
MHz	dBµV/m	Degree	Meter	H/ V	dBµV/m	dB	dB	dBµV/m	dBµV/m	dB
500	50.1	200	1.2	V	18.5	4.9	28.4	45.1	46	-0.9
75	56.2	180	1.2	V	9.5	1.8	28.6	38.9	40	-1.1
250	56.9	200	1.2	V	11.7	3.4	27.6	44.4	46	-1.6
375	52.1	200	3	Н	14.9	4.1	27.9	43.2	46	-2.8
500	47.9	270	3	Н	18.5	4.9	28.4	42.9	46	-3.1
250	55.3	300	3	Н	11.7	3.4	27.6	42.8	46	-3.2
276.5	53.7	270	3	Н	12.6	3.5	27.5	42.3	46	-3.7
125	53.4	200	1.2	V	12.3	2.3	28.3	39.7	43.5	-3.8
172.8	51.3	180	1.2	V	13.3	2.8	27.9	39.5	43.5	-4.0
125	52.4	300	2.5	Н	12.3	2.3	28.3	38.7	43.5	-4.8
400	48.6	200	1.2	V	15.8	4.6	28.2	40.8	46	-5.2
375	49.6	180	1.2	V	14.9	4.1	27.9	40.7	46	-5.3
400	47.6	300	2.5	Н	15.8	4.6	28.2	39.8	46	-6.2
225	52.3	200	1.2	V	11.3	3.1	27.7	39.0	46	-7.0
225	52.3	270	3	Н	11.3	3.1	27.7	39.0	46	-7.0
150	48.7	200	1.2	V	13.0	2.5	28.2	36.0	43.5	-7.5
150	48.7	200	1.2	V	13.0	2.5	28.2	36.0	43.5	-7.5
172.8	47.6	180	1.2	V	13.3	2.8	27.9	35.8	43.5	-7.7
276.5	49.6	270	3	Н	12.6	3.5	27.5	38.2	46	-7.8
150	47.9	270	3	Н	13.0	2.5	28.2	35.2	43.5	-8.3
172.8	46.4	300	2.5	Н	13.3	2.8	27.9	34.6	43.5	-8.9
75	47.5	200	3	Н	9.5	1.8	28.6	30.2	40	-9.8